

### **Search Notes (continued)**



**Application/Control No.**

10/706,429

**Examiner**

Richale L. Haney

**Applicant(s)/Patent under  
Reexamination**

SAFFRAN, MICHAEL D.

**SEARCHED**

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner